	Application No.	Applicant(s)	
A1 = 4" = = = P A11 = = = = lo :1:4o >	09/916,519	SATO, MASAO	
Notice of Allowability	Examiner	Art Unit	
	Hoon Song	2882	
The MAILING DATE of this communication appears claims being allowable, PROSECUTION ON THE MERITS IS (Corewith (or previously mailed), a Notice of Allowance (PTOL-85) or DTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIGHT the Office or upon petition by the applicant. See 37 CFR 1.313 and the Office of the core in	OR REMAINS) CLOSED in rother appropriate commi HTS. This application is s	n this application. If not include unication will be mailed in due	led course. THIS
This communication is responsive to response filed on Febru	iary 4, 2004.		
☐ The allowed claim(s) is/are <u>1-26</u> .			
$oxed{\boxtimes}$ The drawings filed on <u>27 July 2001</u> are accepted by the Exar	miner.		
Acknowledgment is made of a claim for foreign priority unde	er 35 U.S.C. § 119(a)-(d)	or (f).	
a) ☐ All b) ☐ Some* c) ⊠ None of the:			
 Certified copies of the priority documents have b 	een received.		
Certified copies of the priority documents have b	een received in Application	on No	
Copies of the certified copies of the priority docu	ments have been receive	d in this national stage applica	ation from the
International Bureau (PCT Rule 17.2(a)).			
* Certified copies not received:			
Applicant has THREE MONTHS FROM THE "MAILING DATE" of noted below. Failure to timely comply will result in ABANDONMEI THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.—————	NT of this application.	e a reply complying with the re	quirements
☐ A SUBSTITUTE OATH OR DECLARATION must be submitted INFORMAL PATENT APPLICATION (PTO-152) which gives			NOTICE OF
☐ CORRECTED DRAWINGS (as "replacement sheets") must !	oe submitted.		
(a) ☐ including changes required by the Notice of Draftspersor	n's Patent Drawing Review	v (PTO-948) attached	
1) ☐ hereto or 2) ☐ to Paper No./Mail Date			
(b) ☐ including changes required by the attached Examiner's A Paper No./Mail Date	Amendment / Comment or	r in the Office action of	
Identifying indicia such as the application number (see 37 CFR 1.84 each sheet. Replacement sheet(s) should be labeled as such in the			e back) of
□ DEPOSIT OF and/or INFORMATION about the deposit attached Examiner's comment regarding REQUIREMENT FO			Note the
tachment(s) ☐ Notice of References Cited (PTO-892)	5. ☐ Notice of In	formal Patent Application (PT	'O-152)
☐ Notice of Draftperson's Patent Drawing Review (PTO-948)	<u> </u>	ummary (PTO-413),	0 102)
	Paper No.	/Mail Date	
Information Disclosure Statements (PTO-1449 or PTO/SB/08) Paper No./Mail Date), /. [] Examiner's	Amendment/Comment	
Examiner's Comment Regarding Requirement for Deposit	8. 🛛 Examiner's	Statement of Reasons for All	owance
of Biological Material	9. 🗌 Other	<u>.</u> .	

Application/Control Number: 09/916,519

Art Unit: 2882

DETAILED ACTION

Allowable Subject Matter

Claims 1-26 are allowed over prior art.

The following is an examiner's statement of reasons for allowance:

None of the prior art teaches or suggests an x-ray fluorescence film thickness measuring device having a liquid nitrogen-less PIN diode x-ray detector or silicon drift chamber used as a first sensor with low counting efficiency but high energy resolution for detecting x-ray fluorescence generated from a sample, and a proportional counter or a scintillation counter as a second sensor having low energy resolution but high counting efficiency compared to the first senor as claimed in independent claims 1 and 2.

None of the prior art teaches or suggests a fluorescent x-ray film thickness measuring device having focusing means with a first collimator block for focusing a primary x-rays onto microscopic measurement regions in a sample and second collimator block disposed above the first collimator block for receiving primary x-rays from the x-ray generating system and focusing the primary x-rays toward the first collimator block as claimed in independent claims 3 and 22.

None of the prior art teaches or suggests an x-ray fluorescence film thickness measuring device having a first sensor with low counting efficiency but high energy resolution for detecting x-ray fluorescence generated from a sample and a second sensor having low energy resolution but high counting efficiency compared to the first sensor as claimed in independent claim 5.

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Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Hoon Song whose telephone number is (571) 272-2494. The examiner can normally be reached on 8:30 AM - 5 PM, Monday - Friday.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Edward Glick can be reached on (571) 272 - 2490. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

HKS

519/04

EDWARD J. GLICK
PATENT EXAMINER